

Notice of References Cited	Application/Control No. 09/585,553	Applicant(s)/Patent Under Reexamination ONO, SHUJI	
	Examiner Nhan T. Tran	Art Unit 2615	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,823,080	11-2004	Iijima et al.	382/154
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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